## Search Notes



Application/Control	No.

10/631,169 Examiner

Hanh V. Tran

Applicant(s)/Patent under Reexamination

MACKRILL ET AL.
Art Unit

3637

SEARCHED				
Class	Subclass	Date	Examiner	
108	20	10/1/2005	н∨т	
	21			
	147	-		
108	136			
141	74-75			
	83			
141	72 78			
177	184 201	10/1/2005	HVT	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NO (INCLUDING SEARCH	TES   STRATEGY	)
	DATE	EXMR
East text search using various key words	10/1/2005	HVT